

产 品 规 格 书

SPECIFICATIONS FOR PRODUCT

产品类型 TYPE : Crystal Oscillator

产品规格 SPEC : 125MHz/3225/3.3V

产品型号 P/N : CJQ05-1250003320B25

日期 DATE : 2021/05/06

核准及签名			部门 DEPT.
R&D APPR. SIGNATURED			
拟制	审核	批准	频率器件事业部
ISSUE	CHECK	APPROVAL	
Ivan 2021/05/06	Abbey 2021/05/06	Ken 2021/05/06	

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**SMD3.2 * 2.5 Crystal Oscillator****CJQ05-1250003320B25****1. Scope:**

1.1 This specification applies to the RoHS crystal oscillator with a frequency of 125MHz which will be used in electronic equipment.

2. Construction:

2.1 Oscillators series: SMD 3.2x2.5 XO

2.2 Package: SMD 3.2x2.5

3. Electrical Characteristics

3.1 Nominal Frequency: 125MHz

3.2 Frequency Stability: $\pm 25\text{ppm}$
(incl. 25°C tolerance, tolerance over operating temperature range, input voltage change, load change, 1 year aging)

3.3 Aging: $\pm 3\text{ppm/year}$

3.4 Operating Temperature Range: -40°C to $+85^{\circ}\text{C}$

3.5 Storage Temperature Range: -55°C to $+125^{\circ}\text{C}$

3.6 Input Voltage (V_{DD}): $+3.3\text{Vdc}\pm 10\%$

3.7 Input Current (I_{DD}): 40mA max

3.8 Output Waveform: CMOS

3.9 Output Symmetry: $50\pm 10\%$

3.10 Rise/Fall Time: 6ns max

3.11 Output Voltage V_{OL} : 10%VDD
 V_{OH} : 90%VDD

3.12 Output Load: 15pF

3.13 Output State Control: Enable/disable

3.14 Start-up Time: 5ms max

3.15 Standby current: 10 μ A max

3.16 Period Jitter: 40ps max (PK-PK)

3.17 Phase Jitter(RMS): 2ps max (12KHz to 20MHz)

3.18 Oscillation mode: QMEMS

3.19 Others: Not recommended for safety applications

4. Reliability Specifications

This is the quality control and quality assurance and reliability tests performance data for the RoHS 125MHz SMD 3.2x2.5 XO

related to the specification and approval sheet provided by JSCJ .

Standard test condition (TEMP.: 20±15°C. Relative humidity: 65±20%)

For any discrepancy in GO/NG, test will be done at TEMP.25±2°C. R.H. 65±5%.

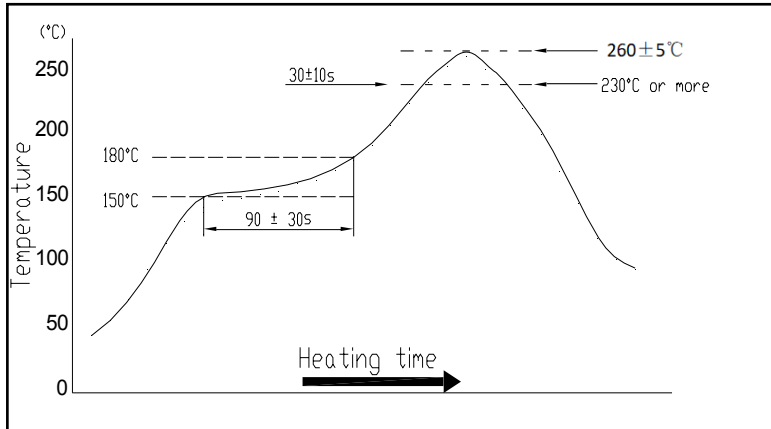
NO.	ITEM	SPECIFICATION	TEST METHOD
4.1	Temperature Cycle (GB/T 2423.22-2002, Method Nb)	Frequency change after test≤± 5ppm.	10 cycles from -55°C to 125°C. Measurement taken after DUT being left at room temperature for 24±2 hours.
4.2	Low Temperature Storage (GB/T 2423.1-2001, Method Aa)	Frequency change after test≤± 5ppm.	Spending 72 hrs at -55°C±3°C constant temperature. Measurement taken after DUT being left at room temperature for 24±2 hours.
4.3	High Temperature Storage (GB/T 2423.2-2001, Method Ba)	Frequency change after test≤± 5ppm.	Spending 72 hrs at 125°C±3°C constant temperature. Measurement taken after DUT being left at room temperature for 24±2 hours.
4.4	Humidity (GB/T 2423.3-2006, Method Cab)	Frequency change after test≤± 5ppm.	Spending 96 hrs at 40 °C ± 3 °C, with 90± 3% R.H. Measurement taken after DUT being left at room temperature for 24±2 hours.
4.5	Vibration (GB/T 2423.10-1995, Method Fc)	Frequency change after test≤± 5ppm.	Apply 0.75mm vibration at sweep frequency 10~500 Hz, for 2h. 10 cycles in each direction of 3 axis. Measurement taken after 1 hour.
4.6	Shock (GB/T 2423.5-1995, Method Ea)	Frequency change after test≤± 5ppm. No visible damages.	Peak 1000m/s ² , normal width 6ms half sine wave form, 3.7m/s, 3 perpendicular axis of samples, 3 cycles / direction, total 18 cycles. Measurement taken after 1 hour.
4.7	Drop (GB/T 2423.8-1995, Method Ed)	Frequency change after test≤± 5ppm. No visible damages.	Free drop to the wooden plate from 1.0 m heights for 3 times.
4.8	Solderability (GB/T 2423.28-2005, Method Tc)	Terminals shall be covered more then 95% with solder.	In 245 ± 5°C solder bath for 2 ± 0.5 seconds. There is no need to do functioned test. 8-12X magnifier.
4.9	Terminal Strength (JIS-C-6429 Method 1 & 2)	No visible damage	Mount on a glass-epoxy board (100x50x1.6mm), then bend to 2mm displacement (velocity 1mm/sec) and keep for 5 seconds. or pulling force 0.5 kg for at least 60 seconds.
4.10	Resistance to Soldering Heat (GB/T 2423.28-2005, Test Tb Method 1B)	Frequency change after test≤± 5ppm.	Passed through the re-flow oven under the following condition. Preheat to 150°C±5°C for 60 to 120sec, and peak 265°C±5°C for 10s±3sec. Measurement taken after DUT being left at room temperature for at 24±2 hours.
4.11	OTHERS		

5. Recommended Reflow soldering condition (SMD)

■ Solder profile

Peak: $260\pm 5^{\circ}\text{C}$ Soldering zone: 230°C or more, $30\pm 10\text{s}$.

Pre-heating zone 1: $150\sim 180^{\circ}\text{C}$, $90\pm 30\text{s}$



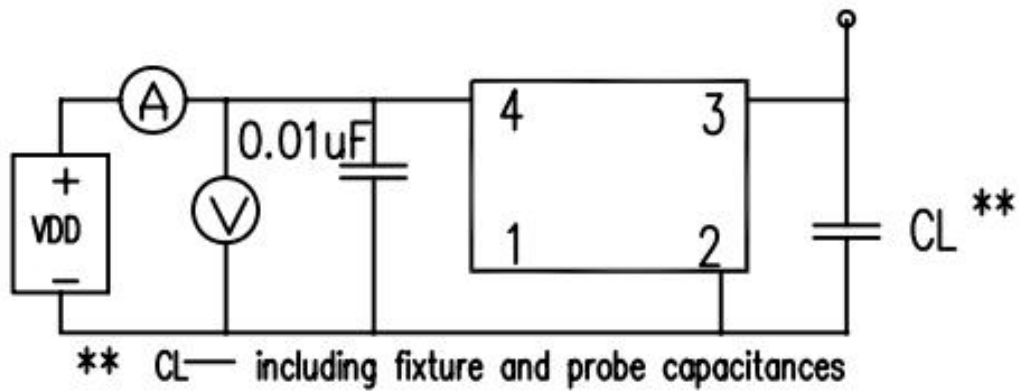
Temperature profile for reflow soldering

6. Soldering iron method

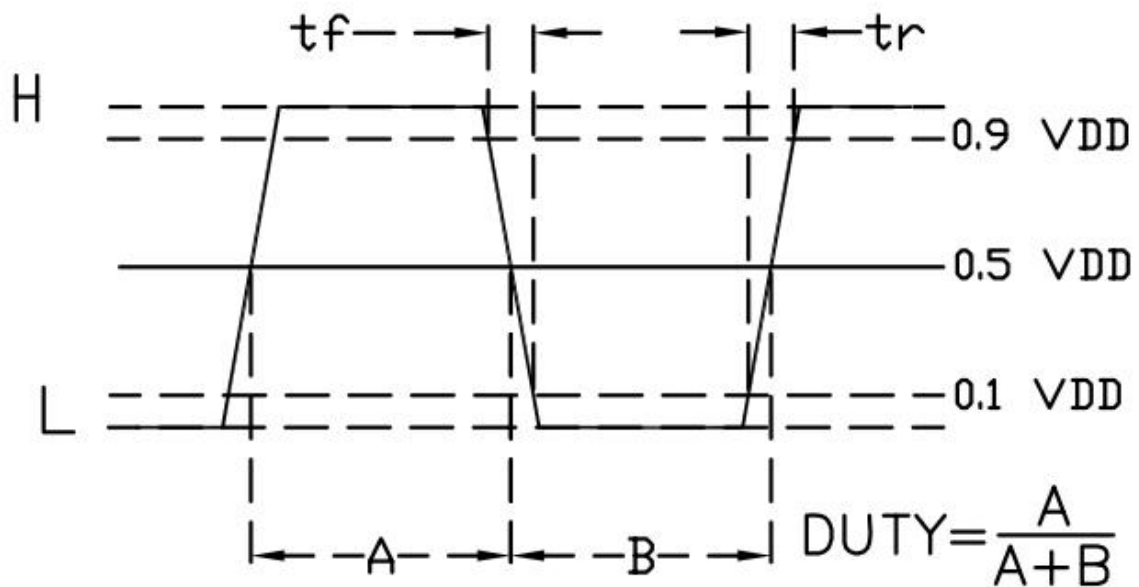
Bit temperature: $350\pm 10^{\circ}\text{C}$ Application time of soldering iron: $3+1\text{ s}$

For other procedures, refer to IEC 60068-2-20.

CMOS TEST CIRCUIT

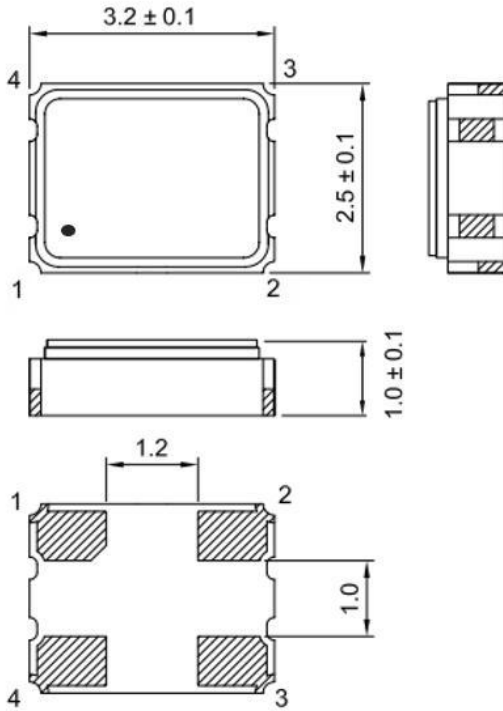


TYPICAL CMOS WAVE FORM



Package Outline Dimensions

Units:mm



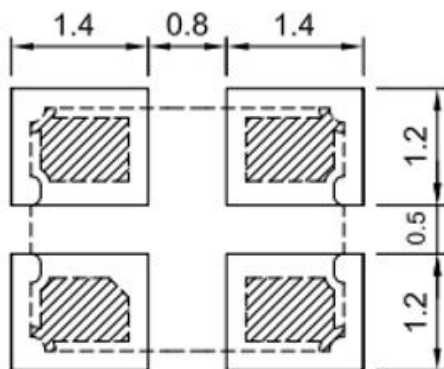
PIN CONNECTION

P/N	CJQ05
1	Enable/Disable*
2	GND
3	Output
4	VDD

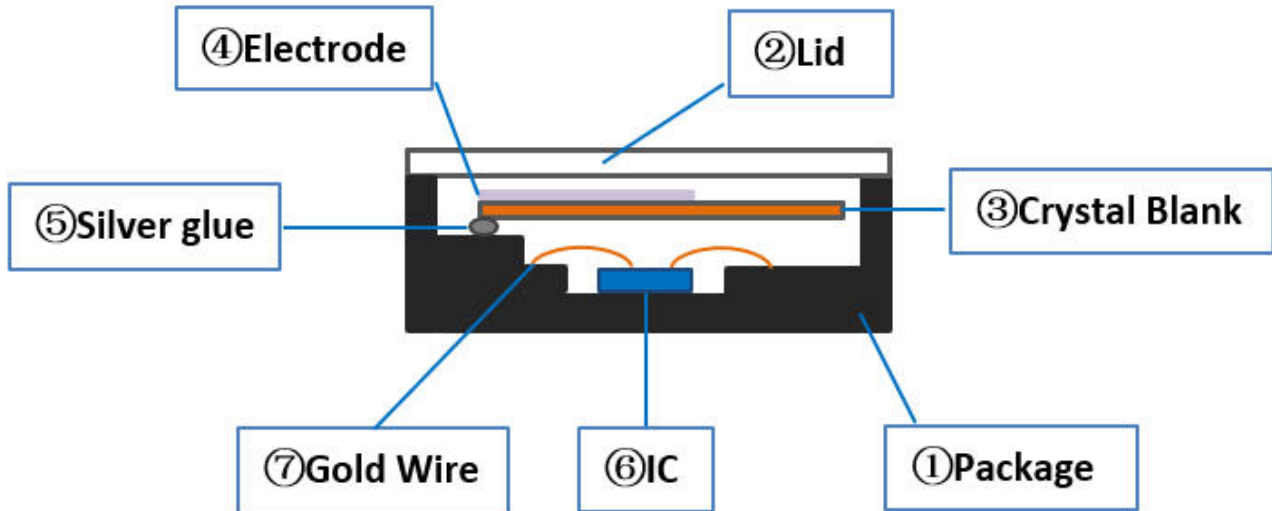
*

Enable/Disable functional description
 When pin1 goes high ($\geq 0.7VDD$) or open, the Oscillator in normal operation and has output in frequency. When pin1 goes low ($\leq 0.3VDD$), the oscillator stops and the oscillator output (Pin3) becomes high impedance.

Suggested Pad Layout

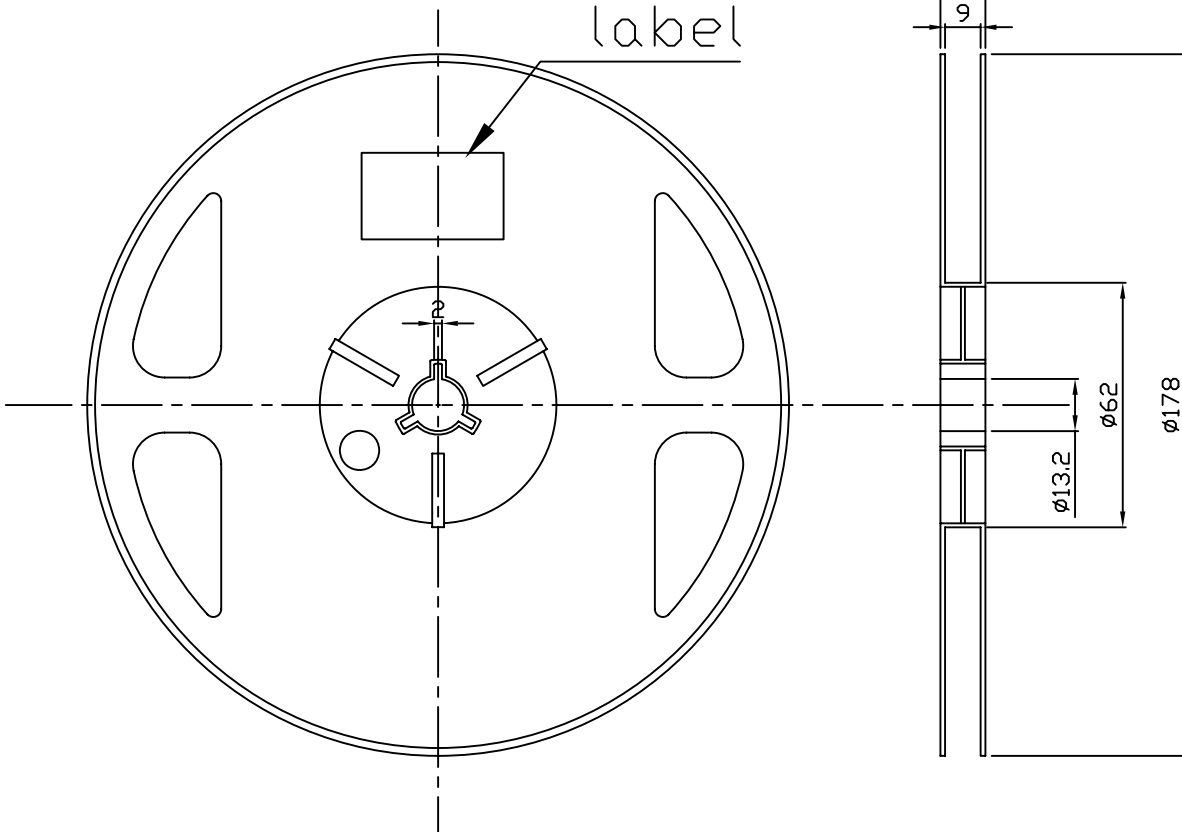


Inside Structure

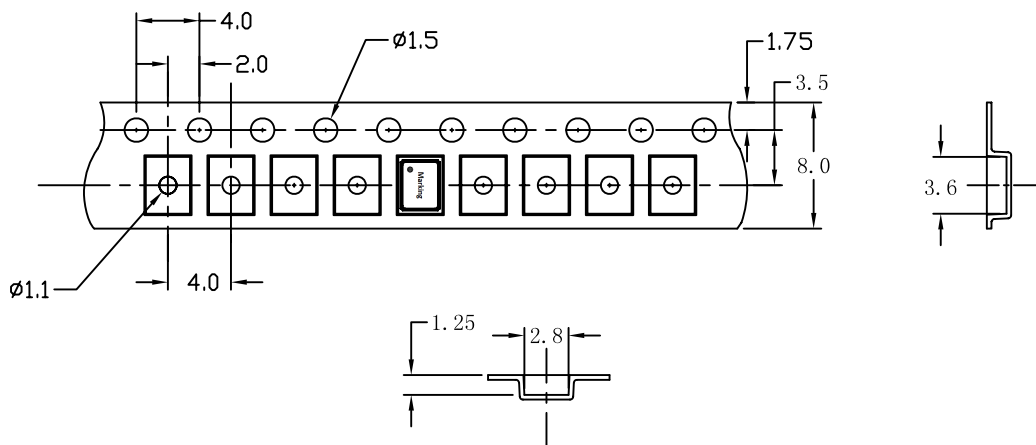


No.	Components	Materials
1	Package	Ceramic(Al_2O_3)
2	Lid	KV(Fe/Ni/Co)
3	Crystal blank	SiO_2
4	Electrode	Ag, Cr
5	Silver glue	Ag, CH_3OH , SiO_2
6	IC	Si
7	Gold Wire	Au

REEL DIMENSIONS
label



EMBOSSED TYPE DIMENSIONS



USER FEED DIRECTION

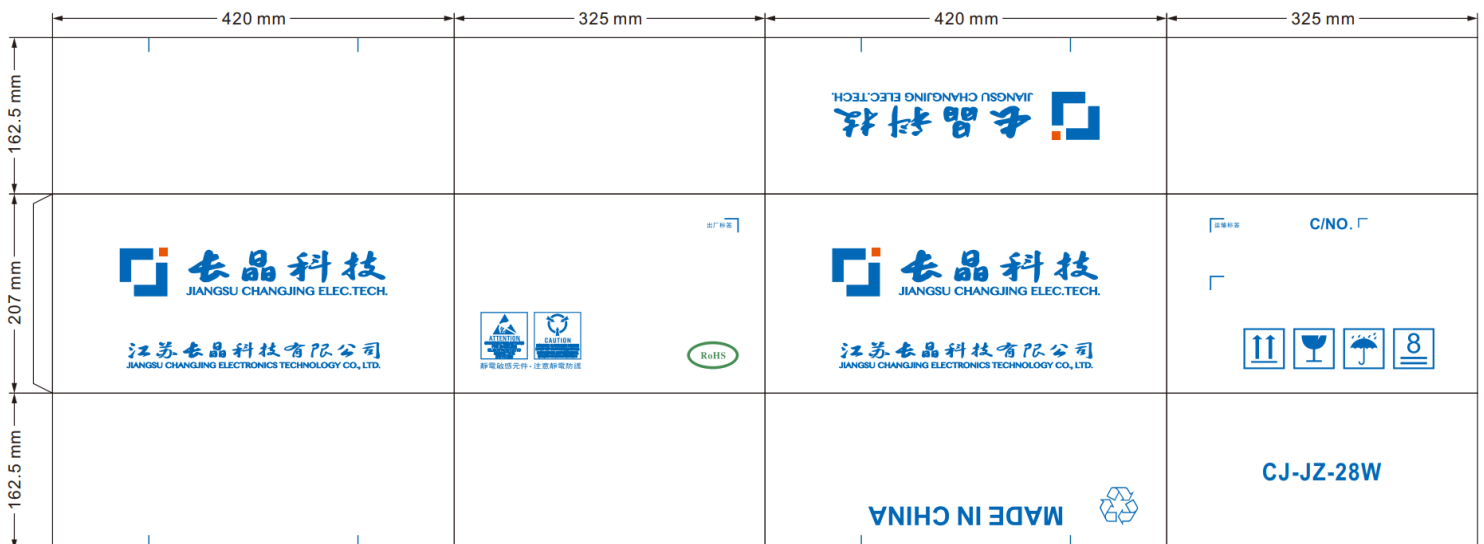


Package

Inside package



Outside package



NOTICE

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